



**3.3 V 8M × 64/72-Bit 1 Bank SDRAM Module
3.3 V 16M × 64/72-Bit 2 Bank SDRAM Module**

168-Pin Unbuffered DIMM Modules

- 168-Pin unbuffered 8-Byte Dual-In-Line SDRAM Modules for PC main memory applications
- PC100 and PC133 versions
- 1 bank 8M × 64, 8M × 72 and 2 bank 16M × 64, 16M × 72 organization
- Optimized for byte-write non-parity (x64) or ECC (x72) applications
- JEDEC standard Synchronous DRAMs (SDRAM)
- Fully PC board layout compatible to INTEL's Rev. 1.0 Module Specification
- SDRAM Performance:

		-7.5	-8	Unit
		PC133	PC100	
f_{CK}	Clock Frequency (max.)	133	100	MHz
t_{AC}	Clock Access Time	5.4	6	ns

- Programmed Latencies:

Product Speed		CL	t_{RCD}	t_{RP}
-7.5	PC133	3	3	3
-8	PC100	2	2	2

- Single +3.3 V(±0.3 V) Power Supply
- Programmable \overline{CAS} Latency, Burst Length, and Wrap Sequence (Sequential and Interleave)
- Auto-Refresh (CBR) and Self-Refresh
- Decoupling capacitors mounted on substrate
- All inputs and outputs are LVTTTL compatible
- Serial Presence Detect with E²PROM
- Utilizes 8M × 8 SDRAMs in TSOPII-54 packages with 4096 refresh cycles every 64 ms
- 133.35 mm × 31.75 mm × 4,00 mm card size with gold-contact pads

The HYS 64(72)V8300GU and HYS 64(72)V16220GU are industry-standard 168-pin 8-byte Dual In-line Memory Modules (DIMMs) which are organized as 8M × 64, 8M × 72 in 1 bank and 16M × 64 and 16M × 72 in two banks of high-speed memory arrays designed with 64M Synchronous DRAMs (SDRAMs) for non-parity and ECC applications. The DIMMs use -7.5 speed sorted 8M × 8 SDRAM devices in TSOP54 packages to meet the PC133-333 requirements and use -8 components for the standard PC100-222 applications. Decoupling capacitors are mounted on the PC board. The PC board design is in accordance with INTEL's PC SDRAM Rev. 1.0 Module Specification. The DIMMs have Serial Presence Detect, implemented with a serial E²PROM using the two-pin I²C protocol. The first 128 bytes are utilized by the DIMM manufacturer and the second 128 bytes are available to the end user. All INFINEON 168-pin DIMMs provide a high performance, flexible 8-byte interface in a 133.35 mm long footprint, with 1.25" (31.75 mm) height.

Ordering Information

Type	Code	Package	Descriptions	Module Height
64 MByte DIMMs				
HYS 64V8300GU-7.5-...	PC133-333-520	L-DIM-168-33	133 Mhz 8M × 64 1 bank SDRAM module	1.25"
HYS 72V8300GU-7.5-...	PC133-333-520	L-DIM-168-33	133 Mhz 8M × 72 1 bank SDRAM module	1.25"
HYS 64V8300GU-8-...	PC100-222-620	L-DIM-168-33	100 MHz 8M × 64 1 bank SDRAM module	1.25"
HYS 72V8300GU-8-...	PC100-222-620	L-DIM-168-33	100 MHz 8M × 72 1 bank SDRAM module	1.25"
128 MByte DIMMs				
HYS 64V16220GU-7.5-...	PC133-333-520	L-DIM-168-30	133 MHz 16M × 64 2 bank SDRAM module	1.25"
HYS 72V16220GU-7.5-...	PC133-333-520	L-DIM-168-30	133 Mhz 16M × 72 2 bank SDRAM module	1.25"
HYS 64V16220GU-8-...	PC100-222-620	L-DIM-168-30	100 MHz 16M × 64 2 bank SDRAM module	1.25"
HYS 72V16220GU-8-...	PC100-222-620	L-DIM-168-30	100 Mhz 16M × 72 2 bank SDRAM module	1.25"

Note: All part numbers end with a place code (not shown), designating the die revision. Consult factory for current revision. Example: HYS 64V8300GU-8-B, indicates that Rev.B dies are used for SDRAM components.

Pin Definitions and Functions

A0-A11	Address Inputs	\overline{WE}	Read/Write Input	V_{SS}	Ground
BA0, BA1	Bank Selects	$\overline{CKE0}, \overline{CKE1}$	Clock Enable	SCL	Clock for SPD
DQ0 - DQ63	Data Input/Output	CLK0 - CLK3	Clock Input	SDA	Serial Data Out
CB0-CB7	Check Bits (x72 only)	DQMB0 - DQMB7	Data Mask	N.C.	No Connection
\overline{RAS}	Row Address Strobe	$\overline{CS0} - \overline{CS3}$	Chip Select	-	-
\overline{CAS}	Column Address Strobe	V_{DD}	Power (+3.3 V)	-	-

Address Format

	Part Number	Rows	Columns	Bank Select	Refresh	Period	Interval
8M × 64	HYS 64V8300GU	12	9	2	4k	64 ms	15,6 μs
8M × 72	HYS 72V8300GU	12	9	2	4k	64 ms	15,6 μs
16M × 64	HYS 64V16220GU	12	9	2	4k	64 ms	15,6 μs
16M × 72	HYS 72V16220GU	12	9	2	4k	64 ms	15,6 μs

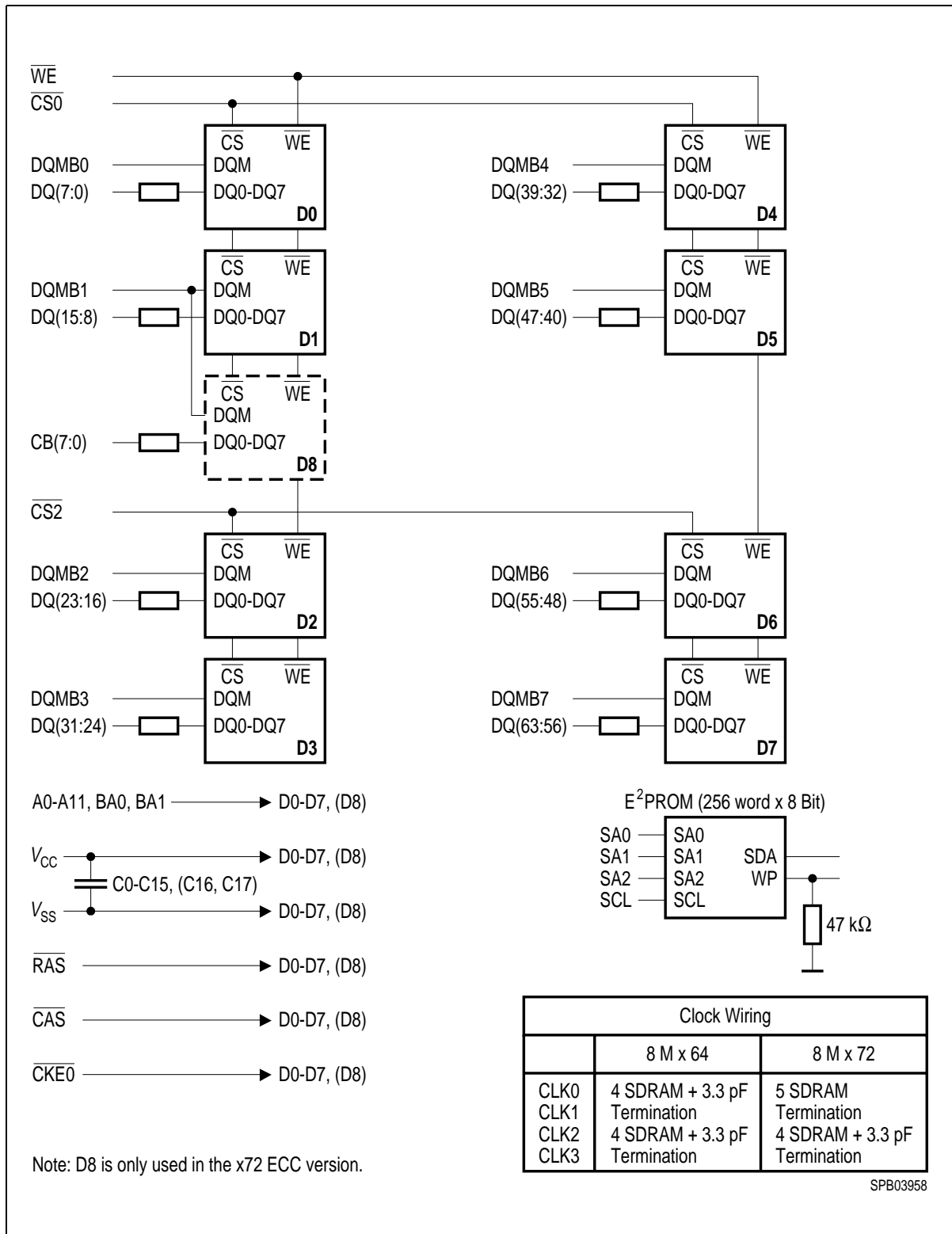
Pin Configuration

PIN#	Symbol	PIN#	Symbol	PIN#	Symbol	PIN#	Symbol
1	V_{SS}	43	V_{SS}	85	V_{SS}	127	V_{SS}
2	DQ0	44	DU	86	DQ32	128	CKE0
3	DQ1	45	CS2	87	DQ33	129	CS3
4	DQ2	46	DQMB2	88	DQ34	130	DQMB6
5	DQ3	47	DQMB3	89	DQ35	131	DQMB7
6	V_{DD}	48	DU	90	V_{DD}	132	N.C.
7	DQ4	49	V_{DD}	91	DQ36	133	V_{DD}
8	DQ5	50	N.C.	92	DQ37	134	N.C.
9	DQ6	51	N.C.	93	DQ38	135	N.C.
10	DQ7	52	N.C. (CB2)	94	DQ39	136	CB6
11	DQ8	53	N.C. (CB3)	95	DQ40	137	CB7
12	V_{SS}	54	V_{SS}	96	V_{SS}	138	V_{SS}
13	DQ9	55	DQ16	97	DQ41	139	DQ48
14	DQ10	56	DQ17	98	DQ42	140	DQ49
15	DQ11	57	DQ18	99	DQ43	141	DQ50
16	DQ12	58	DQ19	100	DQ44	142	DQ51

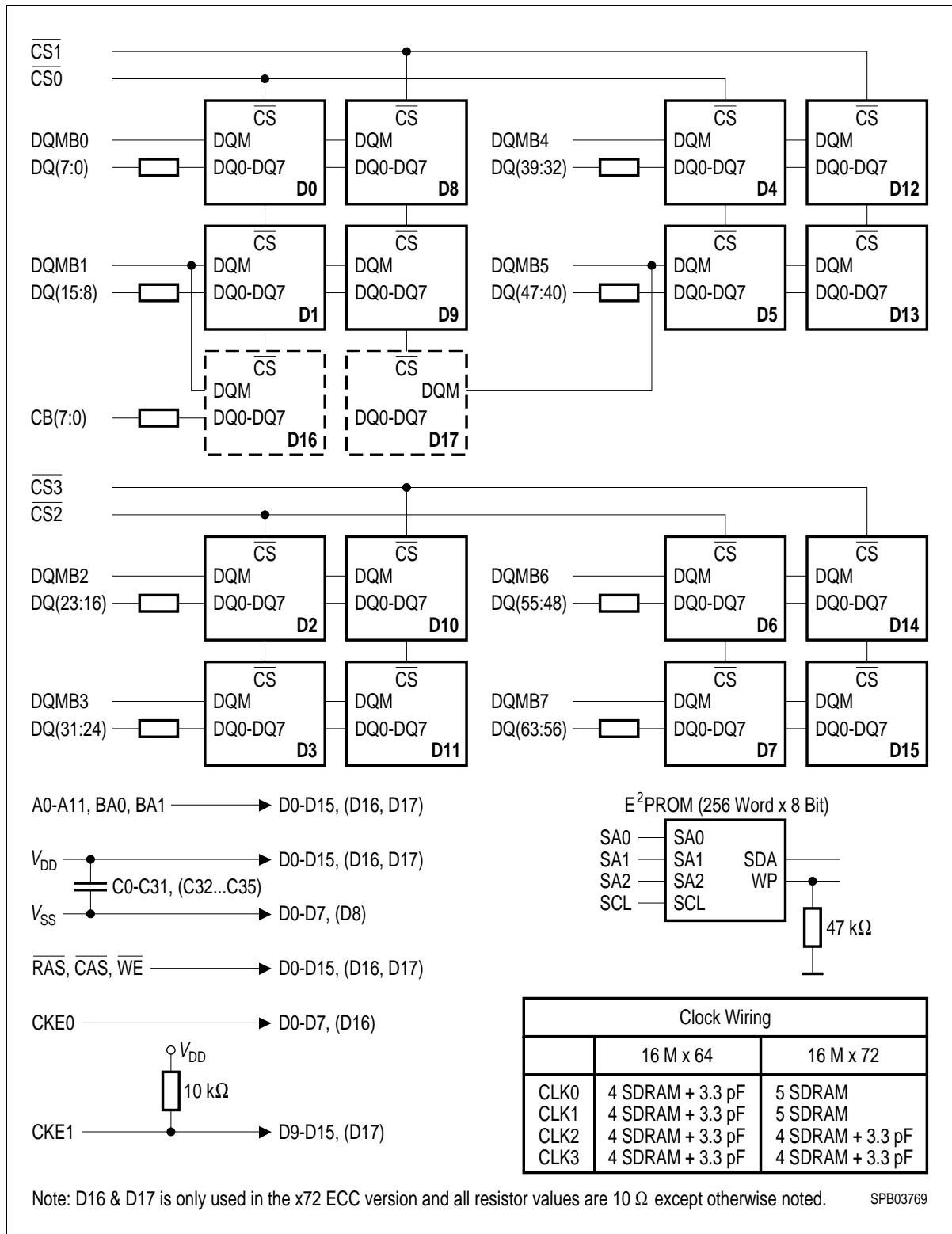
Pin Configuration (cont'd)

PIN#	Symbol	PIN#	Symbol	PIN#	Symbol	PIN#	Symbol
17	DQ13	59	V _{DD}	101	DQ45	143	V _{DD}
18	V _{DD}	60	DQ20	102	V _{DD}	144	DQ52
19	DQ14	61	N.C.	103	DQ46	145	N.C.
20	DQ15	62	DU	104	DQ47	146	DU
21	N.C. (CB0)	63	CKE1	105	N.C. (CB4)	147	N.C.
22	N.C. (CB1)	64	V _{SS}	106	N.C. (CB5)	148	V _{SS}
23	V _{SS}	65	DQ21	107	V _{SS}	149	DQ53
24	N.C.	66	DQ22	108	N.C.	150	DQ54
25	N.C.	67	DQ23	109	N.C.	151	DQ55
26	V _{DD}	68	V _{SS}	110	V _{DD}	152	V _{SS}
27	WE	69	DQ24	111	CAS	153	DQ56
28	DQMB0	70	DQ25	112	DQMB4	154	DQ57
29	DQMB1	71	DQ26	113	DQMB5	155	DQ58
30	CS0	72	DQ27	114	CS1	156	DQ59
31	DU	73	V _{DD}	115	RAS	157	V _{DD}
32	V _{SS}	74	DQ28	116	V _{SS}	158	DQ60
33	A0	75	DQ29	117	A1	159	DQ61
34	A2	76	DQ30	118	A3	160	DQ62
35	A4	77	DQ31	119	A5	161	DQ63
36	A6	78	V _{SS}	120	A7	162	V _{SS}
37	A8	79	CLK2	121	A9	163	CLK3
38	A10	80	N.C.	122	BA0	164	N.C.
39	BA1	81	WP	123	A11	165	SA0
40	V _{DD}	82	SDA	124	V _{DD}	166	SA1
41	V _{DD}	83	SCL	125	CLK1	167	SA2
42	CLK0	84	V _{DD}	126	N.C.	168	V _{DD}

Note: Pin names in parentheses are for the x72 ECC versions; example: Pin 106 = (CB5).



Block Diagram for 8M × 64/72 SDRAM DIMM Modules (HYS 64/72V8300GU)



Block Diagram for 16M × 64/72 SDRAM DIMM Modules (HYS 64/72V16220GU)

DC Characteristics
 $T_A = 0 \text{ to } 70 \text{ }^\circ\text{C}; V_{SS} = 0 \text{ V}; V_{DD}, V_{DDQ} = 3.3 \text{ V} \pm 0.3 \text{ V}$

Parameter	Symbol	Limit Values		Unit
		min.	max.	
Input High Voltage	V_{IH}	2.0	$V_{DD} + 0.3$	V
Input Low Voltage	V_{IL}	-0.5	0.8	V
Output High Voltage ($I_{OUT} = -4.0 \text{ mA}$)	V_{OH}	2.4	-	V
Output Low Voltage ($I_{OUT} = 4.0 \text{ mA}$)	V_{OL}	-	0.4	V
Input Leakage Current, any input ($0 \text{ V} < V_{IN} < 3.6 \text{ V}$, all other inputs = 0 V)	$I_{I(L)}$	-40	40	μA
Output Leakage Current (DQ is disabled, $0 \text{ V} < V_{OUT} < V_{DD}$)	$I_{O(L)}$	-40	40	μA

Capacitance
 $T_A = 0 \text{ to } 70 \text{ }^\circ\text{C}; V_{DD} = 3.3 \text{ V} \pm 0.3 \text{ V}, f = 1 \text{ MHz}$

Parameter	Symbol	Limit Values				Unit
		max. 8M × 64	max. 8M × 72	max. 16M × 64	max. 16M × 72	
Input Capacitance (A0 to A11, BA0, BA1, $\overline{\text{RAS}}$, $\overline{\text{CAS}}$, $\overline{\text{WE}}$)	C_{I1}	65	72	105	144	pF
Input Capacitance (CS0 - CS3)	C_{CS}	32	40	32	40	pF
Input Capacitance (CLK0 - CLK3)	C_{CLK}	38	40	40	43	pF
Input Capacitance (CKE0, CKE1)	C_{CKE}	65	72	65	72	pF
Input Capacitance (DQMB0 - DQMB7)	C_{I4}	13	13	20	20	pF
Input/Output Capacitance (DQ0 - DQ63, CB0 - CB7)	C_{IO}	10	10	17	17	pF
Input Capacitance (SCL, SA0-2)	C_{SC}	8	8	8	8	pF
Input/Output Capacitance	C_{SD}	8	8	8	8	pF

Operating Currents per SDRAM Component ¹⁾

$T_A = 0$ to 70 °C, $V_{DD} = 3.3$ V ± 0.3 V

(Recommended Operating Conditions unless otherwise noted)

Parameter	Test Condition	Symbol	-7.5	-8	Unit	Note
			max.			
Operating Current $t_{RC} = t_{RCMIN}$, $t_{CK} = t_{CKMIN}$. Outputs open, Burst Length = 4, CL = 3 All banks operated in random access, all banks operated in ping-pong manner to maximize gapless data access	–	I_{CC1}	120	110	mA	¹⁾
Precharge Standby Current in Power Down Mode $\overline{CS} = V_{IH}$ (min.), $CKE \leq V_{IL(MAX)}$	$t_{CK} = \text{min.}$	I_{CC2P}	2	2	mA	¹⁾
	$t_{CK} = \text{Infinity}$	I_{CC2PS}	1.5	1.5	mA	¹⁾
Precharge Stand-by Current in Non-Power Down Mode $\overline{CS} = V_{IH(MIN)}$, $CKE \geq V_{IH(MIN)}$	$t_{CK} = \text{min.}$	I_{CC2N}	40	35	mA	¹⁾
	$t_{CK} = \text{Infinity}$	I_{CC2NS}	15	15	mA	¹⁾
No Operating Current $t_{CK} = \text{min.}$, $\overline{CS} = V_{IH(MIN)}$, active state (max. 4 banks)	$CKE \geq V_{IH(MIN)}$	I_{CC3N}	50	45	mA	¹⁾
	$CKE \leq V_{IL(MAX)}$	I_{CC3P}	8	8	mA	¹⁾
Burst Operating Current $t_{CK} = \text{min.}$, Read command cycling	–	I_{CC4}	80	70	mA	^{1), 2)}
Auto-Refresh Current $t_{CK} = \text{min.}$, Auto-Refresh command cycling	–	I_{CC5}	140	130	mA	¹⁾
Self-Refresh Current Self-Refresh Mode, $CKE = 0.2$ V	–	I_{CC6}	1	1	mA	¹⁾

AC Characteristics ^{3), 4)}
 $T_A = 0 \text{ to } 70 \text{ }^\circ\text{C}; V_{SS} = 0 \text{ V}; V_{DD} = 3.3 \text{ V} \pm 0.3 \text{ V}, t_T = 1 \text{ ns}$

Parameter	Symbol	Limit Values				Unit	Note
		-7.5 PC133-333		-8 PC100-222			
		min.	max.	min.	max.		

Clock and Access Time

Clock Cycle Time	t_{CK}						
$\overline{\text{CAS}}$ Latency = 3		7.5	–	10	–	ns	
$\overline{\text{CAS}}$ Latency = 2		10	–	10	–	ns	
System Frequency	f_{CK}						
$\overline{\text{CAS}}$ Latency = 3		–	133	–	100	MHz	
$\overline{\text{CAS}}$ Latency = 2		–	100	–	100	MHz	
Clock Access Time	t_{AC}						4), 5)
$\overline{\text{CAS}}$ Latency = 3		–	5.4	–	6	ns	
$\overline{\text{CAS}}$ Latency = 2		–	6	–	6	ns	
Clock High Pulse Width	t_{CH}	2.5	–	3	–	ns	6)
Clock Low Pulse Width	t_{CL}	2.5	–	3	–	ns	6)

Setup & Hold Parameters

Input Setup Time	t_{IS}	1.5	–	2	–	ns	7)
Input Hold Time	t_{IH}	0.8	–	1	–	ns	7)
Power Down Mode Entry Time	t_{SB}	–	1	–	1	CLK	8)
Power Down Mode Exit Setup Time	t_{PDE}	1	–	1	–	CLK	9)
Mode Register Setup Time	t_{RSC}	2	–	2	–	CLK	
Transition Time (rise and fall)	t_T	1	–	1	–	ns	–

Common Parameters

$\overline{\text{RAS}}$ to $\overline{\text{CAS}}$ Delay	t_{RCD}	20	–	20	–	ns	–
Precharge Time	t_{RP}	20	–	20	–	ns	–
Active Command Period	t_{RAS}	45	100k	50	100k	ns	–
Cycle Time	t_{RC}	67.5	–	70	–	ns	–
Bank-to-Bank Delay Time	t_{RRD}	15	–	16	–	ns	–
$\overline{\text{CAS}}$ to $\overline{\text{CAS}}$ Delay Time (same bank)	t_{CCD}	1	–	1	–	CLK	–

AC Characteristics (cont'd) ^{3), 4)}

$T_A = 0$ to 70 °C; $V_{SS} = 0$ V; $V_{DD} = 3.3$ V ± 0.3 V, $t_T = 1$ ns

Parameter	Symbol	Limit Values				Unit	Note
		-7.5 PC133-333		-8 PC100-222			
		min.	max.	min.	max.		

Refresh Cycle

Refresh Period (4096 cycles)	t_{REF}	–	64	–	64	ms	
Self-Refresh Exit Time	t_{SREX}	1	–	1	–	CLK	¹⁰⁾

Read Cycle

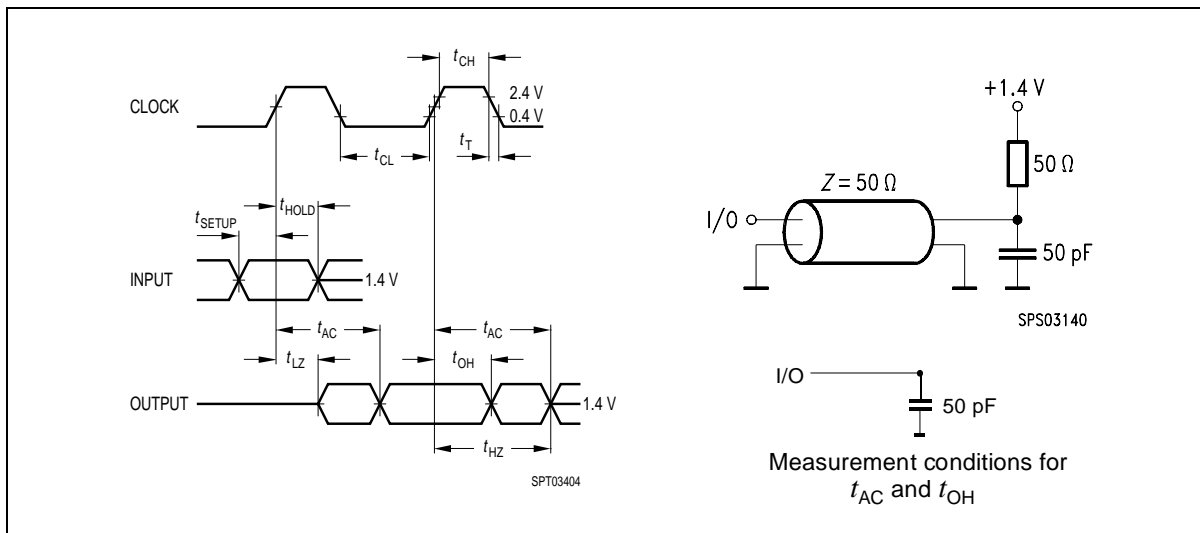
Data Out Hold Time	t_{OH}	3	–	3	–	ns	⁴⁾
Data Out to Low Impedance	t_{LZ}	0	–	0	–	ns	–
Data Out to High Impedance	t_{HZ}	3	7	3	8	ns	¹¹⁾
DQM Data Out Disable Latency	t_{DQZ}	–	2	–	2	CLK	–

Write Cycle

Data Input to Precharge (write recovery)	t_{WR}	2	–	2	–	CLK	–
DQM Write Mask Latency	t_{DQW}	0	–	0	–	CLK	–

Notes

1. These parameters depend on the cycle rate. These values are measured at 133 MHz for -7.5 modules and at 100 Mhz for -8 modules. Input signals are changed once during t_{CK} , except for I_{CC6} and for standby currents when $t_{CK} = \text{infinity}$. All values are shown per memory component.
2. These parameters are measured with continuous data stream during read access and all DQ toggling. CL = 3 and BL = 4 assumed and the V_{DDQ} current is excluded.
3. All AC characteristics are shown on SDRAM component level.
An initial pause of 100 μs is required after power-up, then a Precharge All Banks command must be given followed by eight Auto-Refresh (CBR) cycles before the Mode Register Set Operation can begin.
4. AC timing tests have $V_{IL} = 0.4 \text{ V}$ and $V_{IH} = 2.4 \text{ V}$ with the timing referenced to the 1.4 V crossover point. The transition time is measured between V_{IH} and V_{IL} . All AC measurements assume $t_T = 1 \text{ ns}$ with the AC output load circuit show. Specified t_{AC} and t_{OH} parameters are measured with a 50 pF only, without any resistive termination and with a input signal of 1 V/ns edge rate between 0.8 V and 2.0 V.
5. If clock rising time is longer than 1 ns, a time $(t_T/2 - 0.5) \text{ ns}$ must be added to this parameter.
6. Rated at 1.4 V
7. If t_T is longer than 1 ns, a time $(t_T - 1) \text{ ns}$ has to be added to this parameter.
8. Anytime the Refresh Period has been exceeded, a minimum of two Auto-Refresh (CBR) commands must be given to “wake-up” the device.
9. Timing is asynchronous. If setup time is not met by rising edge of the clock then the CKE signal is assumed latched on the next cycle.
10. Self-Refresh Exit is a synchronous operation and begins on the second positive clock edge after CKE returns high. Self-Refresh Exit is not complete until a time period equal to t_{RC} is satisfied after the Self Refresh Exit command is registered.
11. This is referenced to the time at which the output achieves the open circuit condition, not to output voltage levels.



A Serial Presence Detect storage device—E²PROM—is assembled onto the module. Information about the module configuration, speed, etc. is written into the E²PROM device during module production using a Serial Presence Detect protocol (I²C synchronous 2-wire bus).

SPD-Table for PC133 Modules

Byte#	Description	SPD Entry Value	Hex			
			8M × 64 -7.5	8M × 72 -7.5	16M × 64 -7.5	16M × 72 -7.5
0	Number of SPD Bytes	128	80	80	80	80
1	Total Bytes in Serial PD	256	08	08	08	08
2	Memory Type	SDRAM	04	04	04	04
3	Number of Row Addresses (without BS bits)	12	0C	0C	0C	0C
4	Number of Column Addresses	9	09	09	09	09
5	Number of DIMM Banks	1/2	01	01	02	02
6	Module Data Width	64/72	40	48	40	48
7	Module Data Width (cont'd)	0	00	00	00	00
8	Module Interface Levels	LVTTL	01	01	01	01
9	SDRAM Cycle Time at CL = 3	7.5 ns	75	75	75	75
10	SDRAM Access time from Clock at CL = 3	5.4 ns	54	54	54	54
11	Dimm Config	none/ECC	00	02	00	02
12	Refresh Rate/Type	Self-Refresh, 15.6 μs	80	80	80	80
13	SDRAM Width, primary	x8	08	08	08	08
14	Error Checking SDRAM data width	n/a/x8	00	08	00	08
15	Minimum Clock Delay for Back-to-Back Random Column Address	$t_{CCD} = 1 \text{ CLK}$	01	01	01	01
16	Burst Length supported	1, 2, 4, 8 & full page	8F	8F	8F	8F
17	Number of SDRAM Banks	4	04	04	04	04
18	Supported CAS Latencies	CAS latency = 2 & 3	06	06	06	06
19	CS Latencies	CS latency = 0	01	01	01	01
20	WE Latencies	Write latency = 0	01	01	01	01
21	SDRAM DIMM Module Attributes	non buffered/non reg.	00	00	00	00
22	SDRAM Device Attributes General	$V_{DD} \text{ tol } \pm 10\%$	0E	0E	0E	0E
23	Min. Clock Cycle Time at CAS Latency = 2	10.0 ns	A0	A0	A0	A0
24	Max. Data Access Time from Clock for CL = 2	6.0 ns	60	60	60	60

SPD-Table for PC133 Modules (cont'd)

Byte#	Description	SPD Entry Value	Hex			
			8M × 64 -7.5	8M × 72 -7.5	16M × 64 -7.5	16M × 72 -7.5
25	Minimum Clock Cycle Time at CL = 1	not supported	FF	FF	FF	FF
26	Maximum Data Access Time from Clock at CL = 1	not supported	FF	FF	FF	FF
27	Minimum Row Precharge Time	20 ns	14	14	14	14
28	Minimum Row Active to Row Active delay t_{RRD}	15	0F	0F	0F	0F
29	Minimum RAS to CAS Delay t_{RCD}	20 ns	14	14	14	14
30	Minimum RAS Pulse Width t_{RAS}	45 ns	2D	2D	2D	2D
31	Module Bank Density (per bank)	64 MByte	10	10	10	10
32	SDRAM Input Setup Time	1.5 ns	15	15	15	15
33	SDRAM Input Hold Time	0.8 ns	08	08	08	08
34	SDRAM Data Input Hold Time	1.5 ns	15	15	15	15
35	SDRAM Data Input Setup Time	0.8 ns	08	08	08	08
62-61	Superset Information (may be used in future)	–	FF	FF	FF	FF
62	SPD Revision	Revision 1.2	12	12	12	12
63	Checksum for Bytes 0 - 62	–	82	94	83	95
64-125	Manufacturers Information	–	XX	XX	XX	XX
126	Frequency Specification	–	64	64	64	64
127	Support Details	–	AD	AD	FD	FD
128+	Unused Storage Locations	–	FF	FF	FF	FF

SPD-Table for PC100 Modules

Byte#	Description	SPD Entry Value	Hex			
			8M × 64 -8	8M × 72 -8	16M × 64 -8	16M × 72 -8
0	Number of SPD Bytes	128	80	80	80	80
1	Total Bytes in Serial PD	256	08	08	08	08
2	Memory Type	SDRAM	04	04	04	04
3	Number of Row Addresses (without BS bits)	12	0C	0C	0C	0C
4	Number of Column Addresses	9	09	09	09	09
5	Number of DIMM Banks	1/2	01	01	02	02
6	Module Data Width	64/72	40	48	40	48
7	Module Data Width (cont'd)	0	00	00	00	00
8	Module Interface Levels	LVTTL	01	01	01	01
9	SDRAM Cycle Time at CL = 3	10.0 ns	A0	A0	A0	A0
10	SDRAM Access time from Clock at CL = 3	6.0 ns	60	60	60	60
11	Dimm Config	none/ECC	00	02	00	02
12	Refresh Rate/Type	Self-Refresh, 15.6 μs	80	80	80	80
13	SDRAM Width, primary	x8	08	08	08	08
14	Error Checking SDRAM Data Width	n/a/x8	00	08	00	08
15	Minimum Clock Delay for Back-to-Back Random Column Address	$t_{CCD} = 1 \text{ CLK}$	01	01	01	01
16	Burst Length Supported	1, 2, 4, 8 & full page	8F	8F	8F	8F
17	Number of SDRAM Banks	4	04	04	04	04
18	Supported CAS Latencies	CAS latency = 2 & 3	06	06	06	06
19	CS Latencies	CS latency = 0	01	01	01	01
20	WE Latencies	Write latency = 0	01	01	01	01
21	SDRAM DIMM Module Attributes	non buffered/non reg.	00	00	00	00
22	SDRAM Device Attributes General	V_{DD} tol ±10%	0E	0E	0E	0E
23	Min. Clock Cycle Time at CAS Latency = 2	10.0/12.0 ns	A0	A0	A0	A0
24	Max. Data Access Time from Clock for CL = 2	6.0/7.0 ns	60	60	60	60

SPD-Table for PC100 Modules

Byte#	Description	SPD Entry Value	Hex			
			8M × 64 -8	8M × 72 -8	16M × 64 -8	16M × 72 -8
25	Minimum Clock Cycle Time at CL = 1	not supported	FF	FF	FF	FF
26	Maximum Data Access Time from Clock at CL = 1	not supported	FF	FF	FF	FF
27	Minimum Row Precharge Time	20/30 ns	14	14	14	14
28	Minimum Row Active to Row Active delay t_{RRD}	16/20 ns	10	10	10	10
29	Minimum RAS to CAS delay t_{RCD}	20 ns	14	14	14	14
30	Minimum RAS Pulse Width t_{RAS}	45 ns	2D	2D	2D	2D
31	Module Bank Density (per bank)	64 MByte	10	10	10	10
32	SDRAM Input Setup Time	2 ns	20	20	20	20
33	SDRAM Input Hold Time	1 ns	10	10	10	10
34	SDRAM Data Input Hold Time	2 ns	20	20	20	20
35	SDRAM Data Input Setup Time	1 ns	10	10	10	10
62-61	Superset Information (may be used in future)	–	FF	FF	FF	FF
62	SPD Revision	Revision 1.2	12	12	12	12
63	Checksum for Bytes 0 - 62	–	E0	F2	E1	F3
64-125	Manufacturers Information	–	XX	XX	XX	XX
126	Frequency Specification	100 MHz	64	64	64	64
127	100 MHz Support Details	–	AF	AF	FF	FF
128+	Unused Storage Locations	–	FF	FF	FF	FF

